

# Room temperature Terahertz hot electron bolometric detector based on AlGaAs/GaAs two dimensional electron gas

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**Abstract**— in this paper, we present a hot-electron bolometric detector, which uses the nonlinearities of the heated two-dimensional electron gas medium in AlGaAs/GaAs at room temperature. The cooling process of the electrons is through the phonon-scattering mechanism. The response was measured at the 0.1 – 0.2 THz frequency range. The response was estimated, showing possible application of these detectors in sensing of Terahertz radiation.

## I. INTRODUCTION AND BACKGROUND

Hot-electron bolometers (HEBs) have recently demonstrated much lower receiver noise temperatures in the terahertz (THz) frequency range than have been possible with other types of devices. [1]. Hot electron detectors employing a nonlinear (electron) bolometer device was suggested by Yang et al.[2-3], (see also Yngvesson et al, [4].) In a hot electron bolometer, the electron-electron scattering time is much shorter than the electron-phonon scattering time. Consequently the electron gas has a temperature  $T_e$  which is greater than the lattice temperature under the effect of a dc bias. The electrons are further heated by suitably coupled terahertz radiation, and the resulting change in electron mobility generates a voltage across the device which is proportional to the terahertz power absorbed. The heat capacity of the hot-electron bolometer  $C_e$  is that of the electrons and is very low, so the response time can be short.

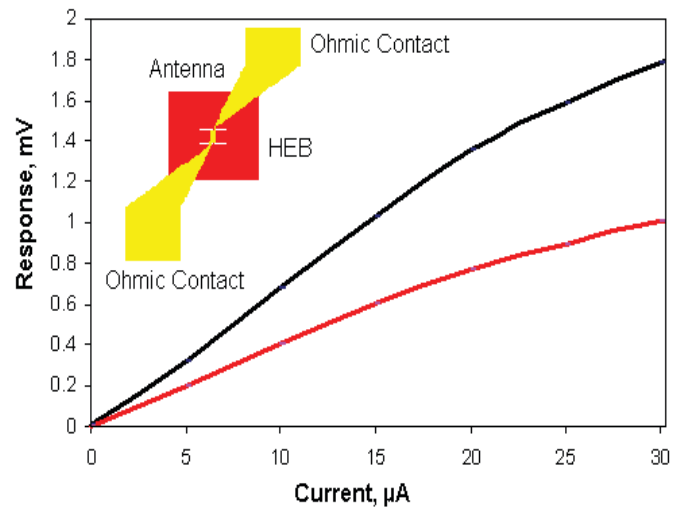
In this letter, we report the experimental results of the terahertz response of a hot electron bolometer constructed using an AlGaAs/GaAs heterostructure. In considering an application driven antenna design we have chosen a twin slot geometry with length  $L_a = 0.32\lambda_0$ , separation  $S_a = 0.16\lambda_0$  and width  $W = 0.05\lambda_0$ , where  $\lambda_0$  is the free-space wavelength. Several similar antennas were investigated.

The fabrication process was conventional for this material. Ohmic contacts are constructed by deposition of an alloy with subsequent annealing at a temperature of approximately 400°C, followed by mesa isolation, then passivation of the wafer with 200 nm thick SiO<sub>2</sub>. Finally, the twin slot antenna over the mesa was deposited by using an alignment mask. The inset of the Fig. 1 shows a schematic of a device designed for 425GHz. A similar design is reported in the literature at various other frequencies [5]. The samples were mounted on a hyper-hemispherical silicon lens to couple in the radiation.

## II. RESULTS

The devices were then placed in a cryostat behind an HDPE vacuum window and multi-mesh THz filters to control the

signal input bandwidth. The signal response to input terahertz radiation was measured as a dc voltage on the open ohmic contact as a function of applied current. The second ohmic contact was grounded. A BWO source was used at 160GHz. Fig. 1 shows the response  $\Delta V$  of two HEBs as function of the applied current. The HEBs were designed for 400GHz (black curve) and 600GHz (red curve).



**Fig.1:** THz response of AlGaAs/GaAs HEBs versus applied current at room temperature and 160GHz for 400GHz(black) and 600GHz(red) devices. Inset: schematic of the device layout.

## III CONCLUSION

We have produced a room temperature hot electron bolometer using conventional processing and demonstrated their efficient detection at terahertz frequencies. The response of these detectors amounts to about 2mV for noise level of 80nV/Hz<sup>0.5</sup>, showing possible application in terahertz imaging application.

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